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AOT1404L/AOB1404L

40V N-Channel Rugged Planar MOSFET

General Description

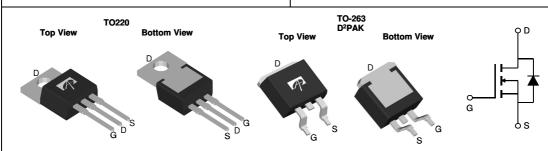
The AOT1404L/AOB1404L uses a robust technology that is designed to provide efficient and reliable power conversion even in the most demanding applications, including motor control. With low $R_{\rm DS(ON)}$ and excellent thermal capability this device is appropriate for high current switching and can endure adverse operating conditions.

Product Summary

 $\begin{array}{ll} V_{DS} & 40V \\ I_D \; (at \; V_{GS} \! = \! 10V) & 220A \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 10V) & < 4.2 m\Omega \end{array}$

100% UIS Tested 100% R_q Tested





Absolute Maximum Ratings T_A=25℃ unless otherwise noted **Parameter** Symbol Maximum Units Drain-Source Voltage V_{DS} 40 Gate-Source Voltage V_{GS} ±20 V $T_C = 25^{\circ}$ 220 Continuous Drain Current G T_C=100℃ 157 Α Pulsed Drain Current C 500 I_{DM} $T_A = 25\%$ 15 Continuous Drain Α I_{DSM} Current T_A=70℃ 11 Avalanche Current C 140 Α I_{AS} , I_{AR} Avalanche energy L=0.1mH ^C 980 mJ $\mathsf{E}_{\mathsf{AS}},\,\mathsf{E}_{\mathsf{AR}}$ T_C=25℃ 417 P_D W T_C=100℃ Power Dissipation B 208 T_A=25℃ 2.1 P_{DSM} W Power Dissipation ^A T_A=70℃ 1.3 T_J, T_{STG} -55 to 175 \mathcal{C} Junction and Storage Temperature Range

Thermal Characteristics										
Parameter		Symbol Typ		Max	Units					
Maximum Junction-to-Ambient A	t ≤ 10s	D	12	15	℃/W					
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	48	60	℃/W					
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	0.3	0.36	℃/W					



Electrical Characteristics (T_J=25℃ unless otherwise noted)

Symbol	Parameter	eter Conditions		Min	Тур	Max	Units				
STATIC PARAMETERS											
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V		40			V				
I _{DSS}	Zero Gate Voltage Drain Current	V_{DS} =40V, V_{GS} =0V	T 55%			1	μΑ				
		T _J =55℃				5	_				
I _{GSS}	Gate-Body leakage current	$V_{DS}=0V$, $V_{GS}=\pm20V$				100	nA				
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$		2.5	3.1	3.7	V				
I _{D(ON)}	On state drain current	V_{GS} =10V, V_{DS} =5V		500			Α				
R _{DS(ON)}	Static Drain-Source On-Resistance	$V_{GS}=10V$, $I_D=20A$			3.6	4.2	mΩ				
		TO220	T _J =125℃		6	7					
	Statio Brain Source on Hooletanes	V_{GS} =10V, I_D =20A									
		TO263		3.3	3.9	mΩ					
g _{FS}	Forward Transconductance	$V_{DS}=5V$, $I_{D}=20A$			55		S				
V_{SD}	Diode Forward Voltage	$I_S=1A, V_{GS}=0V$			0.7	1	V				
I _S	Maximum Body-Diode Continuous Current ^G					220	Α				
DYNAMIC	PARAMETERS										
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =20V, f=1MHz		2840	3568	4300	pF				
C _{oss}	Output Capacitance			960	1388	1810	pF				
C _{rss}	Reverse Transfer Capacitance			85	151	215	рF				
R_g	Gate resistance	$V_{GS}=0V$, $V_{DS}=0V$, $f=1MHz$		1.5	3.1	4.7	Ω				
SWITCHI	NG PARAMETERS										
Q _g (10V)	Total Gate Charge	V _{GS} =10V, V _{DS} =20V, I _D =20A		55	71	86	nC				
Q_{gs}	Gate Source Charge				15		nC				
Q_{gd}	Gate Drain Charge				23		nC				
t _{D(on)}	Turn-On DelayTime	V_{GS} =10V, V_{DS} =20V, R_L =1 Ω , R_{GEN} =3 Ω			16		ns				
t _r	Turn-On Rise Time				30		ns				
t _{D(off)}	Turn-Off DelayTime				54		ns				
t _f	Turn-Off Fall Time				20		ns				
t _{rr}	Body Diode Reverse Recovery Time	I _F =20A, dI/dt=500A/μs		35	45	55	ns				
Q _{rr}	Body Diode Reverse Recovery Charge I _F =20A, dI/dt=500A/μs		225	287	350	nC					
		•									

A. The value of $R_{\theta,JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The Power dissipation P_{DSM} is based on R _{8JA} and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175° C may be used if the PCB allows it.

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Rev1: May 2011 Page 2 of 6 www.aosmd.com

B. The power dissipation P_D is based on $T_{J(MAX)} = 175^\circ$ C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)} = 175^\circ$ C. Ratings are based on low frequency and duty cycles to keep

initial $T_{J}\!=\!25^{\circ}\,$ C. Maximum UIS current limited by test equipment.

D. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case $R_{\theta JC}$ and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

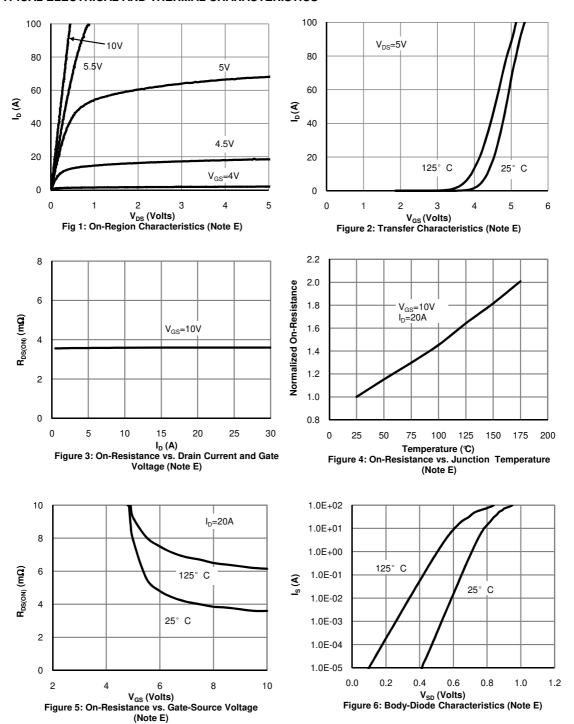
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=175° C. The SOA curve provides a single pulse rating.

G. The maximum current limited by package is 120A.

H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C.

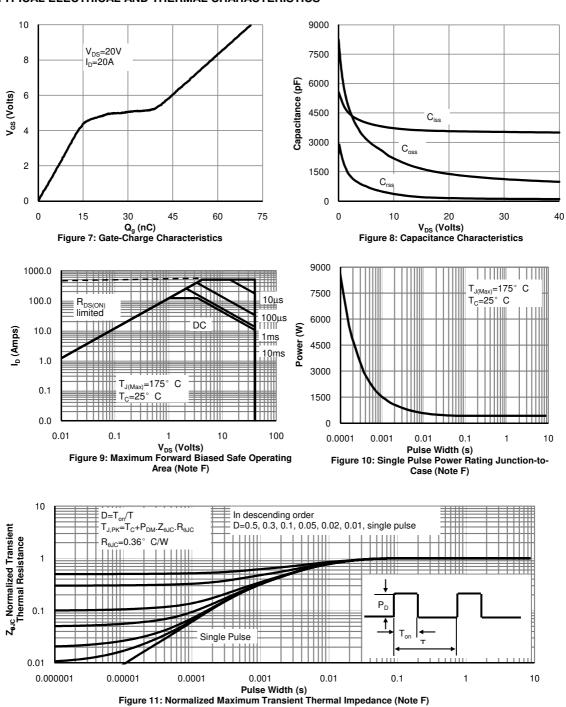


TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS





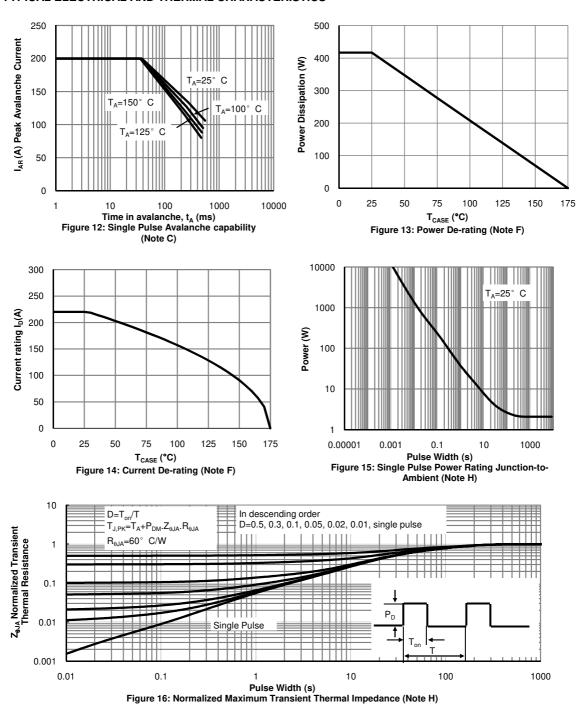
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



Rev1: May 2011 www.aosmd.com Page 4 of 6



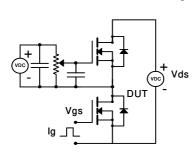
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

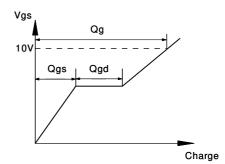


Rev1: May 2011 Page 5 of 6 www.aosmd.com

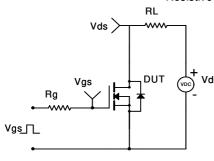


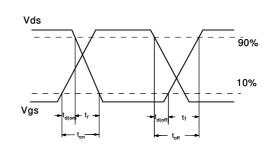
Gate Charge Test Circuit & Waveform



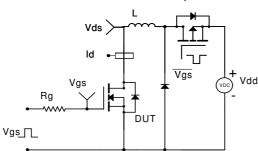


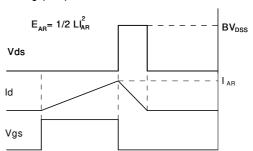
Resistive Switching Test Circuit & Waveforms



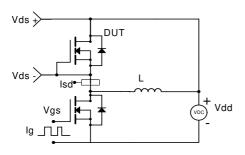


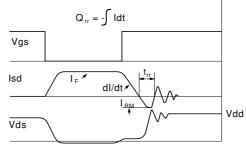
Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms





Rev1: May 2011 **www.aosmd.com** Page 6 of 6